Characterization of Pre-Production Petals for the ATLAS Inner Tracker Strip Detector

Production, Testing and Reliability Parallel, TWEPP 2024, Glasgow, October 4, 2024 **Matthew Basso** (TRIUMF/SFU), On behalf of the ATLAS Collaboration

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Introduction: HL-LHC and ITk

- High-Luminosity LHC (HL-LHC) will enable collisions at ~10 × rate of LHC
 - Will provide **3000 fb⁻¹ of data by its end-of-life**, enabling precision tests of physics
- To accommodate the increased complexity of collisions, ATLAS is upgrading its inner detector: **Inner Tracker (ITk) Upgrade**
 - All silicon with improved radiation hardness and less material
 - \circ Higher granularity: 100M \rightarrow 5000M channels
 - Improved $|\eta|$ coverage: 2.5 \rightarrow 4.0
 - Faster response



23 collisions per BC (LHC)



230 collisions per BC (HL-LHC)







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What makes up an endcap?

- Each endcap consists of **6 disks** along the beam (*z*) axis
- Each disk consists of **32 double-sided petals**
- Each side of a petal is composed of **9 silicon strip sensors**, grouped into **6 modules**
- Each module consists PCB flexes providing readout and power which are glued and bonded to a silicon strip sensor
 - Labelled R0 to R5 in order of increasing radius (4K–7K channels per module)
- This talk will focus on how we **assemble** and **characterize** petals





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A closer look at petals

I HIBS

- Carbon-fibre "core" provides a scaffold for modules
 Ti cooling pipes embedded in core's thermally conductive foam (end-of-life operating temperature: -35 °C)
 Copper-on-polyimide "bus tapes" route data and power
 - Modules are glued to the core and bonded to the bus tape









Exploded view

of core

Automated loading of petals

- Loading ≔ mounting modules onto petals
 - Loading occurs at several international sites (Canada, Germany, and Spain)
- For **uniformity** and **simplicity** of production, an **automated loading system** has been developed, consisting of a robot gantry capable of:
 - Dispensing adhesive
 - Placing modules with micron-level precision using custom vacuum tools
 - Performing post-loading visual capture, module accuracy, and metrology surveys





Also see <u>B. Stelzer's</u> <u>talk</u> at ICHEP2024

Quality metrics for petal loading



- Placement accuracy based on 10 sensor fiducials, allowing its centre and angle to be determined
 - Specification: ±50 µm
 - Most modules are placed within ±20 μm!
- Out-of-plane metrology performed using confocal displacement sensor (or similar means)
 - Height set by adhesive, 110 μm, and sensor thickness, 300 μm
 - Verifies petals are ready for endcap insertion
- Nearly* all petals met specifications



* Nearly, as a few are out-of-spec, but for known reasons







Electrical characterization

- Includes measurements of the HV sensor current (IV) as well as per-channel input noise for each module
 - Current should be < 10 uA @ 550 V bias, noise should be low enough @ 350 V bias to ensure signal-to-noise is high enough at end-of-life
 - Breakdown voltage = voltage at which an immediate and held increase in current occurs
 - Should *not* be impacted by loading
- Petals are tested in a light-tight fridge with controlled a temperature and humidity
 - \circ CO₂ or ethanol coolant flowed through petal core
- Measurements performed using the ITk's data acquisition (DAQ) software

Example of input noise before and after loading

Exploded view of "petal" plot (ENC = electron noise charge)





Noise before and after loading are consistent V

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Input noise [ENC]

Sensor cracking

- ~10% of all sensors on cores exhibited HV breakdown (< 100 V) in the relevant QC temperature range, -35 °C or colder
- Found to be a result of sensor cracks, typically in the sensor areas between flexes
- Mismatch in coefficients of thermal expansion (CTE) of the sensor and the copper in the flexes, resulting in localized stress at cold temperatures





Also see <u>S. Diez's poster</u> at PM2024 and <u>A.</u> <u>Tishelman-Charny's poster</u> at LHCP2024



Initial cracking signatures on petals

- Cracking on any sensor at any temperature ≥ -55 °C is considered problematic
 - To test for cracks, petals have been thermal cycled (TC-ed) from −35 °C to progressively colder temperatures
- Cracks also result in regions of **low/high input noise**
- First petal TC-ed exhibited cracks already at -40 °C → campaign to explore mitigation strategies





Mitigation strategies

- Mechanical simulations have corroborated cracks as locations of high physical stress
 - Also confirmed the importance of the choice of adhesive and its pattern
- <u>Mitigation strategies</u>:
 - Choice of sensor-core adhesive: a stiffer glue (<u>Hysol</u>) instead of a softer glue (<u>SE4445</u>) can reduce stress by 50%
 - **Pattern of sensor-core adhesive**: improved glue coverage to better support regions of high stress
 - **Interposer**: inclusion of a Kapton layer between the flexes and the sensor can reduce stress by 95%
- We'll present results for the first two







Choice of adhesive: Hysol

- Instead of SE4445 in a "snake-like" pattern, a petal was loaded using Hysol in the same pattern and TC-ed from −35 to −70 °C in −5 °C steps
- 20 cracks observed (out of 23 suspected), the first at -35 °C... why?





A closer look at the cracks





Understanding Hysol results

- Simulation informs of the relative (not absolute) change in stress from design choices
 - SE4445 vs. Hysol comparison assumed SE4445 remains softer when cold
- Mechanical analysis revealed SE4445's modulus increases by 2 orders of magnitude below -40 °C
 - Other studies of silicone-based gels align well with this conclusion
- Explains why Hysol did not lead to an improvement on its own





Pattern of adhesive: Hysol

- For the petal with the snake-like Hysol pattern, it was noticed that many cracks occurred along glue edges
 - Edges are not well supported
- Next petal utilized a
 "full-coverage" glue pattern,
 which was optimized to cover
 as much of the core-sensor
 interface as possible



Snake-like

Full-coverage



Results for full-coverage pattern

 Cracks were still observed: while there were fewer cracks (11) compared to the snake-like Hysol pattern, one crack occurred in a region well-supported by glue after the −45 °C TC → an improvement, but not sufficient



Directions of further study

- Remaining 10 cracks occurred around "glue-dot" regions
 - Glue pattern for modules (<u>"True</u> <u>Blue"</u>) utilizes glue dots throughout
 → simulation has shown these to be localized regions of stress
 - Will load a petal using SE4445 and modules built without glue dots
- Interposers have been shown to be a promising route to prevent cracking down to −70 °C → will also load a petal using interposed modules



Picture is for a different petal, but arises from the same mechanism



Summary

- Presented a summary of the procedures for building and testing petals for the ATLAS ITk Upgrade
 - Demonstrated that we are building petals which meet both their mechanical and electrical specifications
- Also presented a summary of the steps taken thus far to address **sensor cracking on cores**
 - <u>Complex issue</u>: at the intersection of module building and petal loading, mitigation strategies take time to fully realize (need to fully load and test petals cold), etc.
 - Two mitigation strategies shown were not sufficient, but the issue is well understood and we have a promising path forward





Thank you for listening! Questions?



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Backup



Example of HV breakdown



Past the -60 °C cycle, breakdown is visible



Summary of observed cracks



